

Notice of References Cited

Application/Control No.

10/021,850

Applicant(s)/Patent Under

Reexamination

QUAKE ET AL.

Examiner

ALEX NOGUEROLA

Art Unit

1753

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6,221,654	04-2001	Quake et al.	435/287.3
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	M	US-			

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	CAPLUS abstract of Kawazumi et al. ("Laser fluorometry using a visible semiconductor laser and an avalanche photodiode for capillary electrophoresis," Analytical Sciences (1995), 11(4), 587-90).
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Alex Noguera
12/13/04